

Form PTO-1449

INFORMATION DISCLOSURE CITATION  
IN AN APPLICATION

(Use several sheets if necessary)

Docket Number  
12-1054Application Number  
*ATA*Applicant  
Murdock, et al.*10/670701*Filing Date  
HerewithGroup Art Unit  
*ATA 285*

## U. S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER						DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROP.
<i>EJ</i>	5	4	6	3	2	5	4	10/31/95	Iyer, et al.		
	5	0	2	6	5	7	4	06/25/91	Economou, et al.		
	5	6	1	8	4	4	6	04/08/97	Nagaishi		
	5	5	6	0	8	3	6	10/01/96	Nagaishi		
	5	0	5	1	6	2	7	09/24/91	Schneier, et al.		
	4	0	9	2	5	5	3	05/30/78	Fang, et al.		
	4	5	0	1	9	7	5	02/26/85	Josephs, et al.		
	4	3	7	1	7	9	6	02/01/83	Takada		
	5	8	9	2	2	4	3	04/06/99	Chan		
	5	9	4	2	9	9	7	08/24/99	Silver, et al.		
<i>EN</i>	5	5	5	2	7	3	5	09/03/96	Kang, et al.		

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	Translation	
						Yes	No

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)


EXAMINER

*EJ*

DATE CONSIDERED

*A-7-04*

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

9/24/03  
Sheet 1 of 2

Form PTO-1449  INFORMATION DISCLOSURE CITATION IN AN APPLICATION  (Use several sheets if necessary)								Docket Number 12-1054	Application Number N/A 101690101				
								Applicant Murdock, et al.					
								Filing Date Herewith	Group Art Unit AIA 2015				
U. S. PATENT DOCUMENTS													
EXAMINER INITIAL	DOCUMENT NUMBER							DATE	NAME		CLASS	SUB CLASS	FILING DATE IF APPROP.
<i>ED</i>	5	4	1	1	9	3	7	05/02/95	Wendt, et al.		/	/	
	5	5	6	0	8	3	6	10/01/96	Nagaishi		/	/	
	5	2	7	8	1	4	0	01/11/94	Chaudhari, et al.		/	/	
	4	7	8	5	4	2	6	11/15/88	Harada, et al.		/	/	
	5	1	3	5	9	0	8	08/04/92	Yang, et al.		/	/	
	5	2	2	5	3	9	4	07/06/93	Yamazaki		/	/	
	5	2	4	8	6	5	8	09/28/93	Yamazaki		/	/	
	4	9	8	5	1	1	7	01/15/91	Kurosawa, et al.		/	/	
	5	2	4	8	6	5	7	09/28/93	Bailey, et al.		/	/	
	5	1	9	6	3	9	5	03/23/93	James, et al.		/	/	
<i>ED</i>	5	5	6	7	3	3	0	10/22/96	Dorothy		/	/	
FOREIGN PATENT DOCUMENTS													
	DOCUMENT NUMBER				DATE	COUNTRY			CLASS	SUB CLASS	Translation		
											Yes	No	
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)													
<i>ED</i>	"Stationary Properties of High-Critical-Temperature Proximity Effect Josephson Junctions" by K. A. Delin and A. W. Kleinsasser, <i>Supercond. Sci. Technol.</i> 9 (1996) pgs 227-240.												
<i>ED</i>	"Use of Paramagnetic or Other Impurities in Josephson Technology" by P. Wolf, <i>IBM Technical Disclosure Bulletin</i> Vol. 18, No. 8 (January 1976) page 2645.												
EXAMINER	<i>C. M.</i>										DATE CONSIDERED 12-7-84		
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.													

**EXAMINER:** Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.